## Notice of References Citegi

	Application/Control No. 09/165,315		Applicant(s)/Patent Under Reexamination TAMURA ET AL.		
i	Examiner		Art Unit		
Į	Christopher E Mahoney		2851	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*	<u> </u>	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,633,678	05-1997	Parulski et al.	348/231.5
L	В	US-5,666,578	09-1997	Oikawa et al.	396/319
L	С	US-6,198,526	03-2001	Ohtsuka, Shuichi	355/40
	D	US-			
	E	US-			<del>                                     </del>
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			<del> </del>
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
0					
Р					
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Т					
	O P Q R S	Country Code-Number-Kind Code  N O P Q R S	Country Code-Number-Kind Code MM-YYYY  N  O  P  Q  R  S	Country Code-Number-Kind Code MM-YYYY Country  N O P Q R S	Country Code-Number-Kind Code   MM-YYYY   Country   Name

## **NON-PATENT DOCUMENTS**

*	$\overline{}$	TOTAL POSSIBLIATO
<u> </u>	<b>├</b> -	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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